Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10750606	BOUCHIER ET AL.	
Examiner	Art Unit	
RAYMOND PHAN	2111	

SEARCHED						
Class	Subclass	Date	Examiner			
710	300-313,315-317,8-19	3/1/08	RP			
709	201-203	3/1/08	RP			
709	217-222	3/1/08	RP			

SEARCH NOTES				
Search Notes	Date	Examiner		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
710	311-312,301-302	3/7/08	RP		

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